

Spectroscopy of ITO coatings in optical and microwave ranges

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Introduction

Among the numerous applications of indium tin oxide (ITO) films in electronics, optics and optoelectronics, the use of ITO coatings for shielding electromagnetic interference in the microwave spectral range occupies a special place [1, 2]. Conductive ITO coatings deposited on a dielectric substrate are widely used as protective windows in optoelectronic devices operating in visible and near-IR ranges. An important task is the development of contactless methods for determining the ITO film parameters. One such method was recently proposed in [3].

The goal of the work: to develop a non-destructive optical method for determining the ITO film parameters and to study the microwave shielding effectiveness of the ITO coatings.

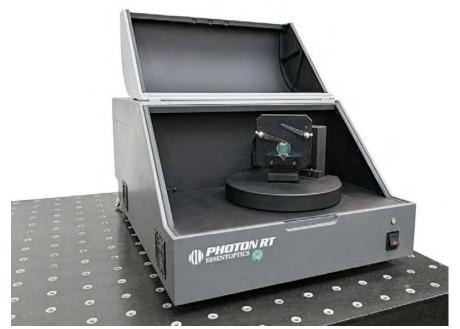
Samples: ITO films on a glass substrate

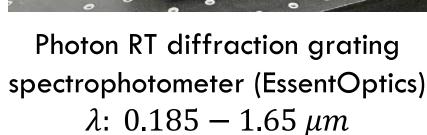


Datasheet of the samples

Sample #	Film thickness d_f , nm	Sheet resistivity $ ho_S$, Ohm/ \Box
1	76	30
2	109	25
3	119	20
4	150	15
5	167	10
6	457	4

Experiments in optical range **Experimental equipment**

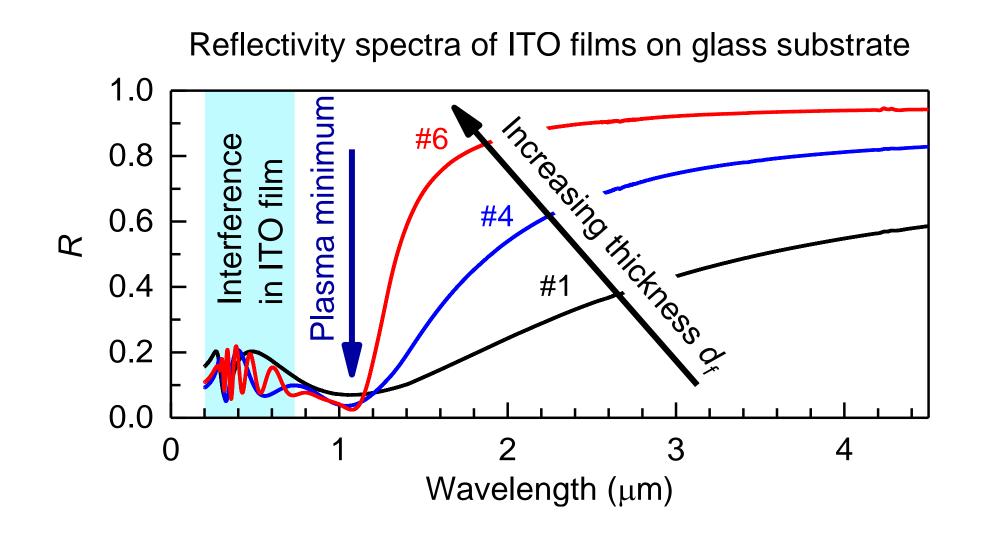


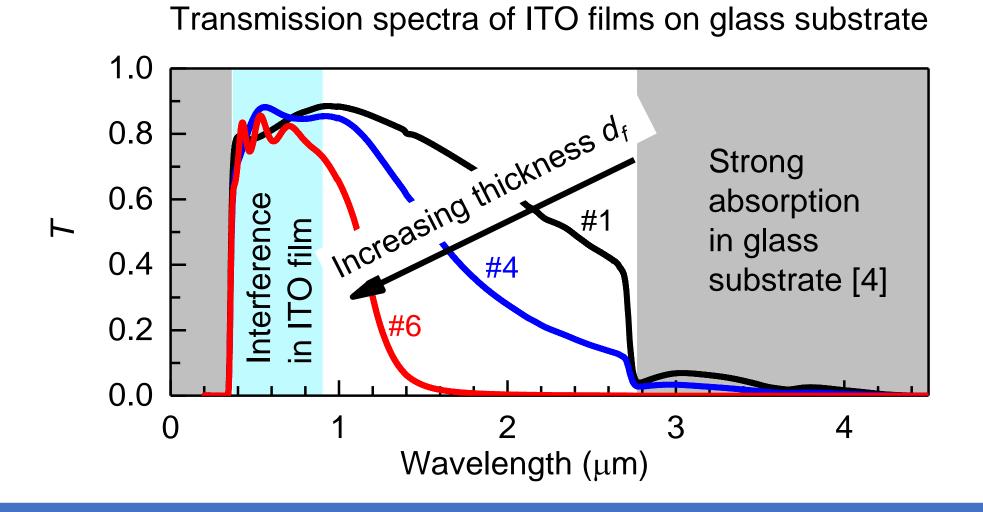




Vertex 70 Fourier-transform infrared spectrometer (Bruker) λ : 0.667 – 335 μm

Experimental results





Summary

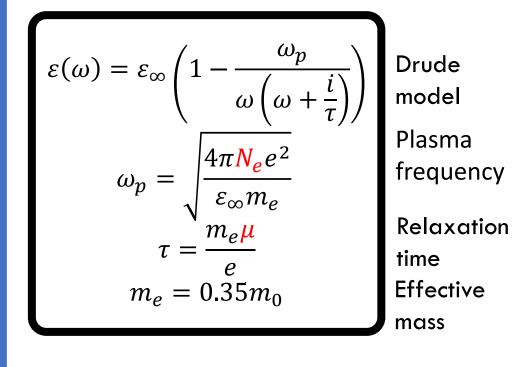
and theoretically experimentally interaction of electromagnetic radiation with the ITO coatings in optical and microwave ranges. A non-destructive method for determining the ITO film parameters (thickness, electron concentration and mobility) has been developed. The method is based on the analysis of reflectivity and transmittance spectra in a wavelength range of 0.2–4.5 μ m. We also examined the reflectivity and transmittance spectra of the samples in microwave range at frequencies of 2.8–23 GHz. It has been found that the microwave shielding efficiency exceeds 26 dB. A relationship has been established between the microwave shielding effectiveness of the ITO coating and its near-infrared reflectivity.

References

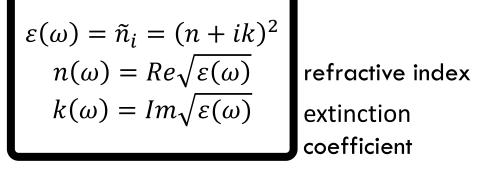
- 1. J.L. Huang, et al., Ceramics international **27**, 363 (2001).
- 2. H. Wang, et al., IEEE MTT-S International Microwave Workshop Series on Advanced Materials and Processes for RF and THz Applications (Ann Arbor, USA, 16-18 July 2018), pp. 1-3.
- 3. D. Ananthanarayanan, et al., Solar Energy 209, 424 (2020).
- 4. V.V. Bassarab, et al., Journal of Optics **25**, 065401 (2023).
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Non-destructive method for determining ITO film parameters

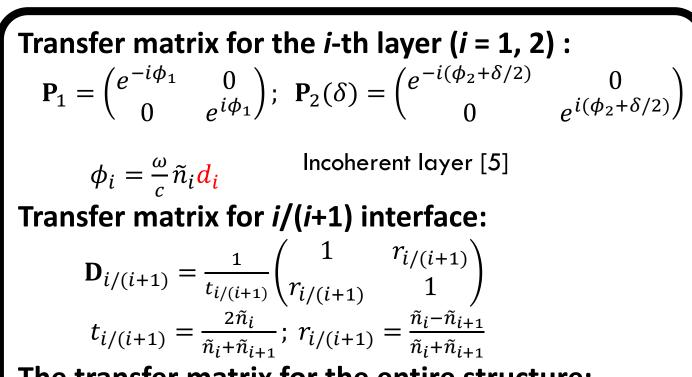
Dielectric permittivity



Fresnel equations:



Transverse matrix method (TMM)



The transfer matrix for the entire structure: $\mathbf{M}(\delta) = \mathbf{D}_{0/1} \mathbf{P}_1 \mathbf{D}_{1/2} \mathbf{P}_2'(\delta) \mathbf{D}_{2/3}$ Reflectivity (R) and transmittance (T) of the structure:

$$R = \frac{1}{2\pi} \int_{-\pi}^{\pi} \left| \frac{1}{\mathbf{M}_{11}(\delta)} \right|^{2} d\delta$$

$$T = \frac{1}{2\pi} \int_{-\pi}^{\pi} \left| \frac{\mathbf{M}_{21}(\delta)}{\mathbf{M}_{11}(\delta)} \right|^{2} d\delta$$



Vacuum (i = 3)

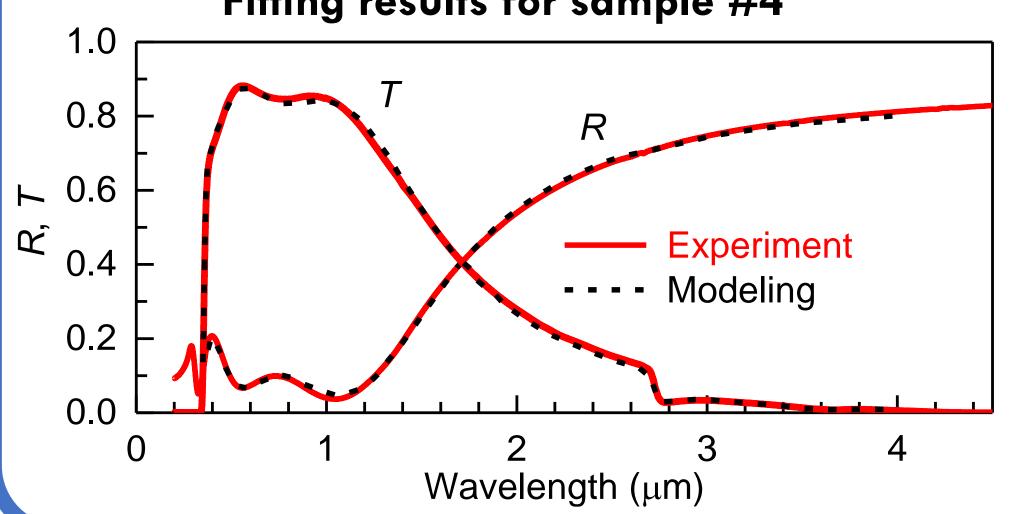
Goal function

$$S = \frac{1}{k} \sum_{j=1}^{k} \frac{1}{n} \sum_{i=1}^{n} (\Delta_{ji})^{2}$$

Fitting parameters

Thickness of the ITO films $d_f \equiv d_1$ Charge carrier concentration N_e Charge carrier mobility μ

Fitting results for sample #4



Best fit parameters: High accuracy!

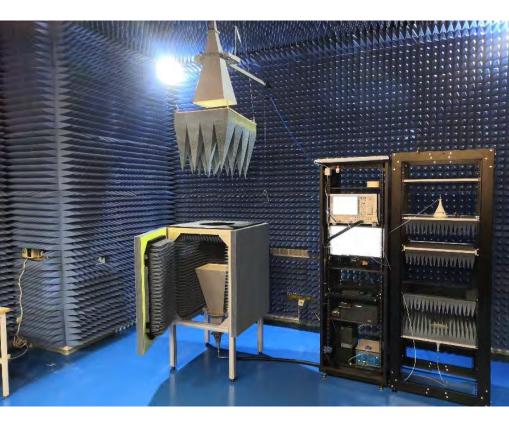
Sample #	d_f , nm	$\frac{N_e}{10^{20}} \times 10^{20} \text{ cm}^{-3}$	μ , $\frac{\text{cm}^2}{\text{V} \times \text{s}}$
#1	68.8 ± 0.3	8.0 ± 0.4	40 ± 2
#4	155.2 ± 0.5	8.1 ± 0.4	37 ± 1
#6	445.0 ± 2	9.9 ± 0.1	44 ± 1

A non-destructive optical method for determining the ITO film parameters d_f, N_e, μ was developed.

Experiments in microwave range

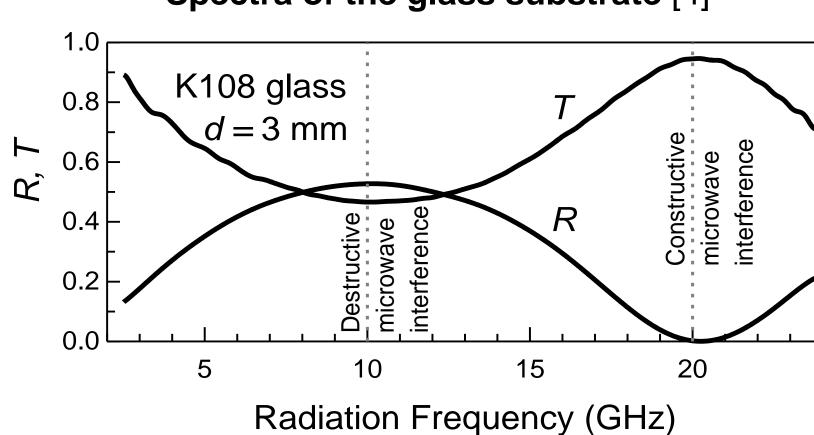
Experimental equipment

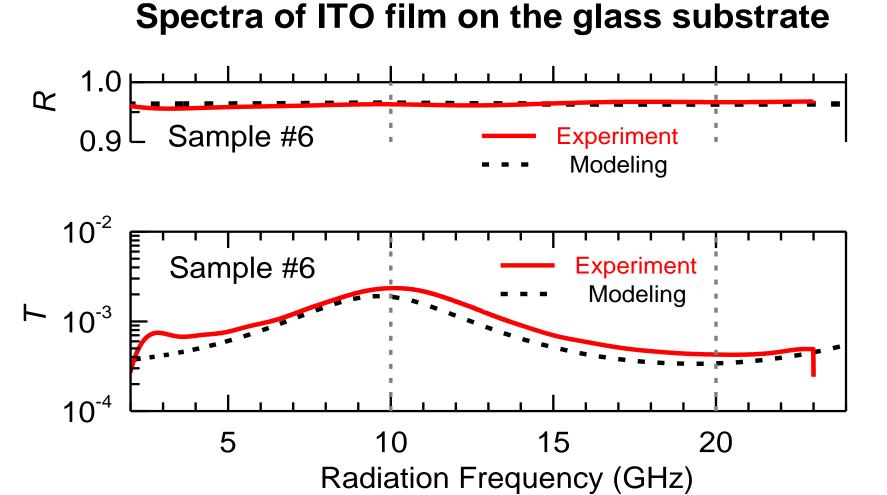
Free-space measurements were performed using an anechoic chamber. Spectral range: 2-24 GHz Spectral resolution: 0.01 GHz



Experimental results

Spectra of the glass substrate [4]



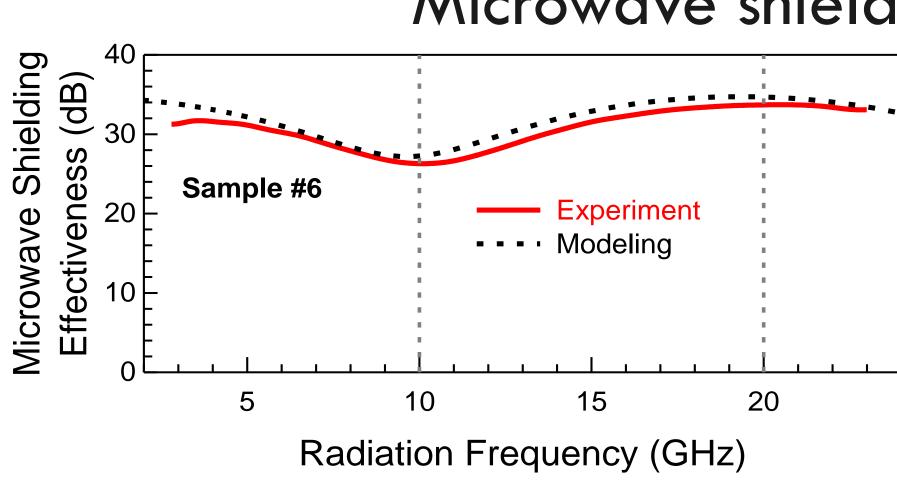


More than 99.7% of microwave radiation is blocked (primarily due to large reflectivity of the ITO film).

The microwave reflectivity and transmittance spectra were simulated using the same theoretical model that was developed for the optical range.

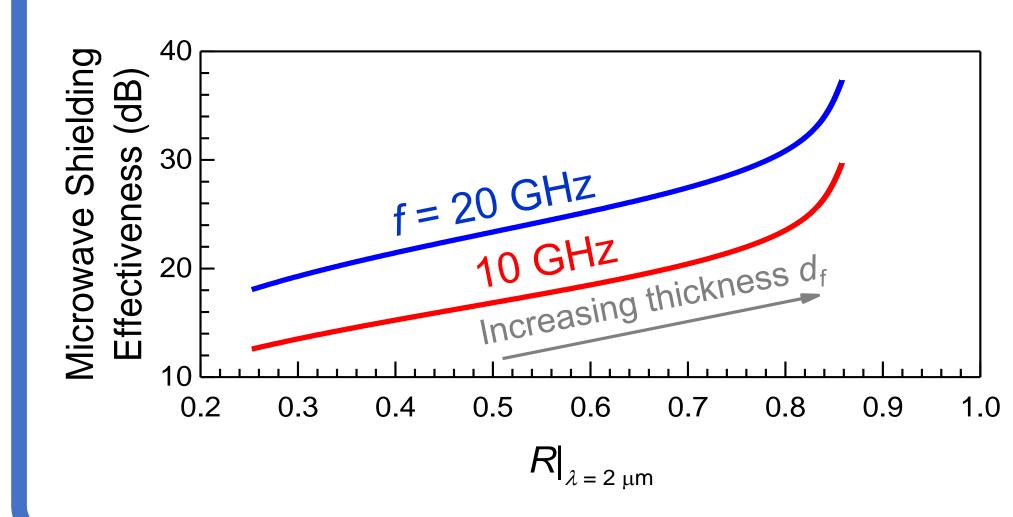
The simulated spectra are in good agreement with the measured ones. This is another argument confirming the high accuracy of determining the ITO film parameters using the method we developed.

Microwave shielding effectiveness



The shielding effectiveness exceeds 26 dB over the entire operating spectral range. The simulated spectra are in good agreement with the measured ones.

Microwave shielding effectiveness of ITO coating versus its near-IR reflectivity



Finally, we have found a correlation between the microwave shielding effectiveness of the ITO coating and its near-infrared reflectivity. The found dependence enables one to predict the ITO film performance in the microwave range at a given frequency using single reflectivity measurement in near-IR range (at a wavelength of $2 \mu m$).